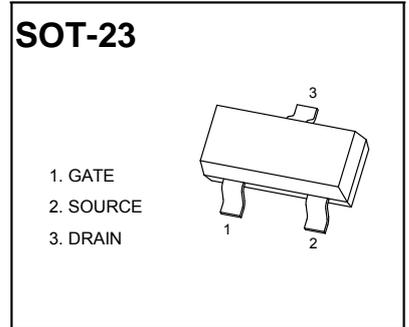
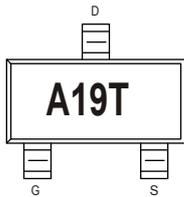


SOT-23 Plastic-Encapsulate MOSFETS
30V P-Channel MOSFET

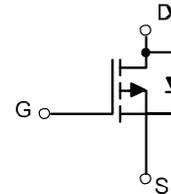
$V_{(BR)DSS}$	$R_{DS(on)Typ}$	$I_D Max$
-30V	44mΩ@-10V	-4.2A
	50mΩ@-4.5V	


FEATURE

High dense cell design for extremely low RDS(ON)
Exceptional on-resistance and maximum DC current capability

MARKING

APPLICATION

- Load/Power Switching
- Interfacing Switching

Equivalent circuit

PACKAGE SPECIFICATIONS

Package	Reel Size	Reel DIA. (mm)	Q'TY/Reel (pcs)	Box Size (mm)	QTY/Box (pcs)	Carton Size (mm)	Q'TY/Carton (pcs)
SOT-23	7'	330	3000	203×203×195	45000	438×438×220	180000

Maximum Ratings and Thermal Characteristics (TA = 25°C unless otherwise noted)

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V_{DS}	-30	V	
Gate-Source Voltage	V_{GS}	±12		
Continuous Drain Current	I_D	$T_A = 25^\circ C$	-4.2	A
		$T_A = 70^\circ C$	-3.2	
Pulsed Drain Current ¹⁾	I_{DM}	-16	A	
Maximum Power Dissipation ²⁾	P_D	$T_A = 25^\circ C$	1.2	W
		$T_A = 70^\circ C$	0.9	
Operating Junction and Storage Temperature Range	T_J, T_{stg}	-50 to 150	°C	
Junction-to-Ambient Thermal Resistance (PCB mounted) ²⁾	R_{thJA}	80	°C/W	

Notes

- ¹⁾ Pulse width limited by maximum junction temperature.
²⁾ Surface Mounted on FR4 Board, $t \leq 5$ sec.

The above data are for reference only.



MOSFET ELECTRICAL CHARACTERISTICS

$T_a=25\text{ }^\circ\text{C}$ unless otherwise specified

Parameter	Symbol	Test Condition	Min	Typ	Max	Units
Off Characteristics						
Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = -250\mu A$	-30			V
Zero gate voltage drain current	I_{DSS}	$V_{DS} = -30V, V_{GS} = 0V$			-1	μA
Gate-source leakage current	I_{GSS}	$V_{GS} = \pm 12V, V_{DS} = 0V$			± 100	nA
On characteristics						
Drain-source on-resistance (note 3)	$R_{DS(on)}$	$V_{GS} = -10V, I_D = -4.2A$		44	55	m
		$V_{GS} = -4.5V, I_D = -3A$		50	60	m
		$V_{GS} = -3.3V, I_D = -3A$		58	75	m
Forward tranconductance (note 3)	g_{FS}	$V_{DS} = -5V, I_D = -5A$	7			S
Gate threshold voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = -250\mu A$	-0.5	-0.8	-1.2	V
Dynamic Characteristics (note 4)						
Input capacitance	C_{iss}	$V_{DS} = -15V, V_{GS} = 0V, f = 1MHz$		655		pF
Output capacitance	C_{oss}			65		pF
Reverse transfer capacitance	C_{rss}			53		pF
Switching Characteristics (note 4)						
Turn-on delay time	$t_{d(on)}$	$V_{GS} = -10V, V_{DS} = -15V,$ $R_L = 3.3\ \Omega, R_{GEN} = 6\ \Omega$		7		ns
Turn-on rise time	t_r			3.8		ns
Turn-off delay time	$t_{d(off)}$			35		ns
Turn-off fall time	t_f			10.5		ns
Drain-source diode characteristics and maximum ratings						
Diode forward voltage (note 3)	V_{SD}	$I_S = 1A, V_{GS} = 0V$			-1	V

Note :

- 3). Pulse test: pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$
- 4). Guaranteed by design, not subject to production testing

Typical Characteristics

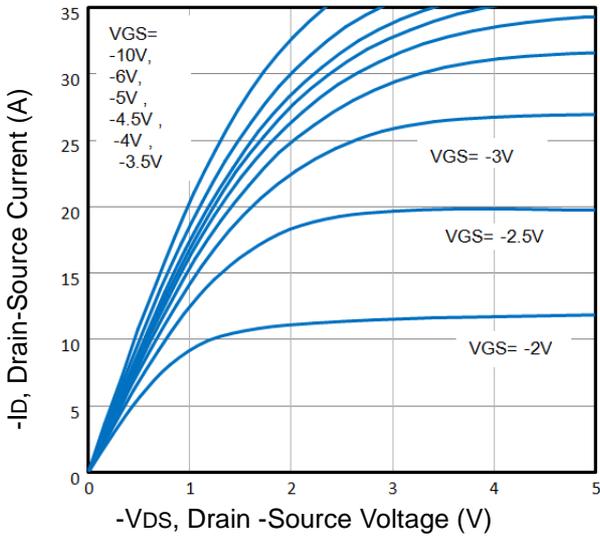


Fig1. Typical Output Characteristics

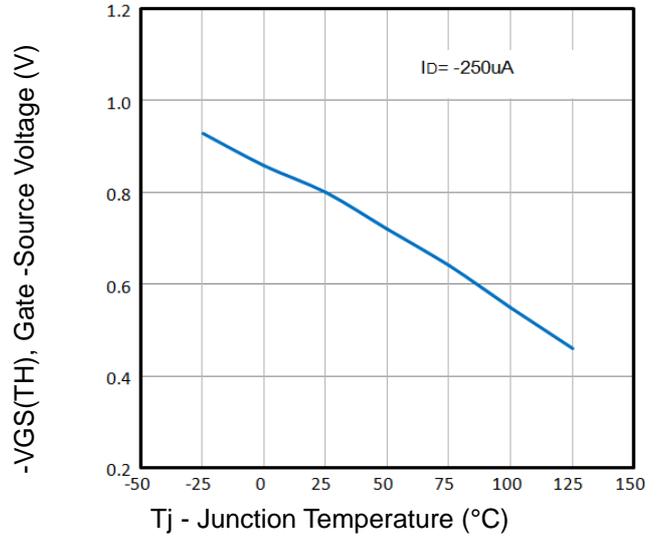


Fig2. Normalized Threshold Voltage Vs. Temperature

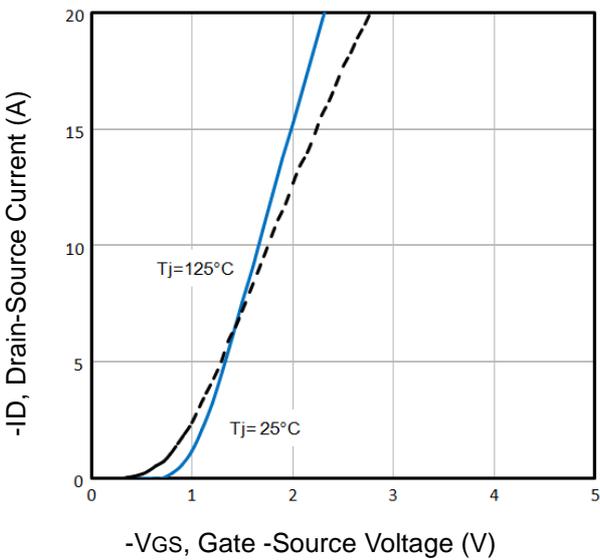


Fig3. Typical Transfer Characteristics

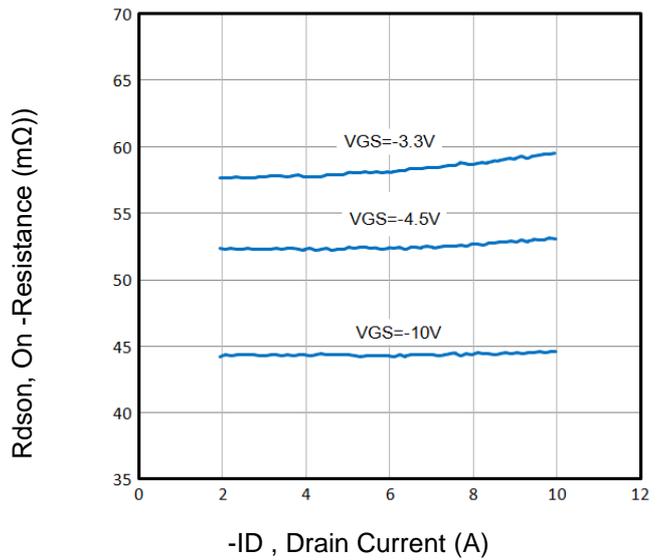


Fig4. On-Resistance vs. Drain Current and Gate

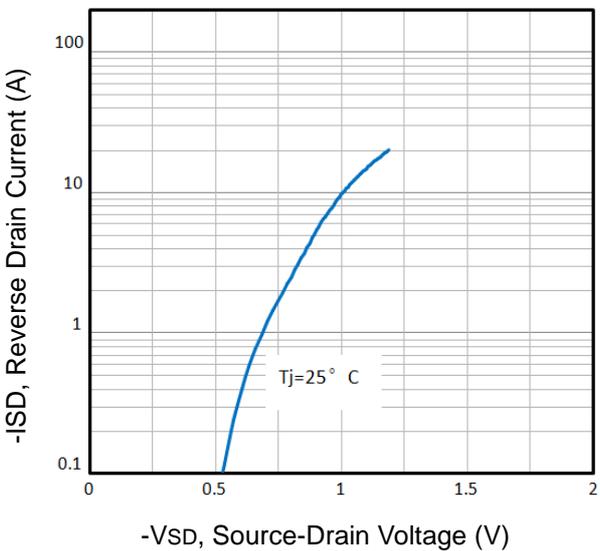


Fig5. Typical Source-Drain Diode Forward Voltage

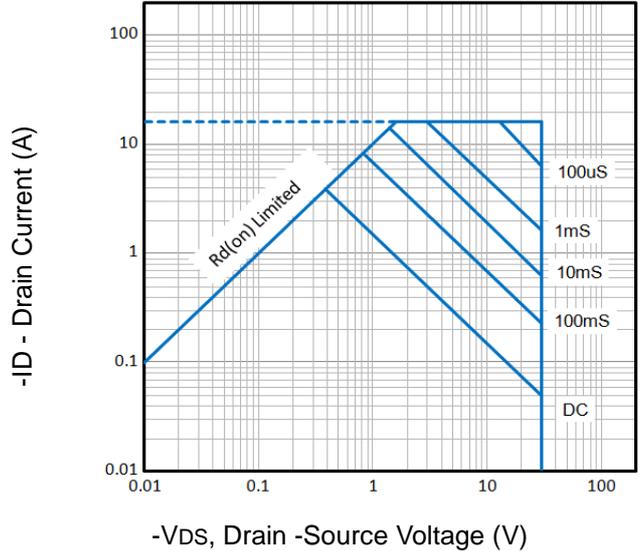


Fig6. Maximum Safe Operating Area

Typical Characteristics

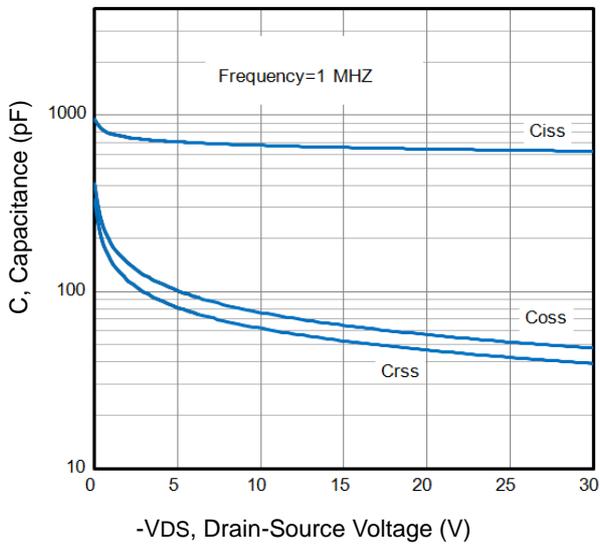


Fig7. Typical Capacitance Vs. Drain-Source Voltage

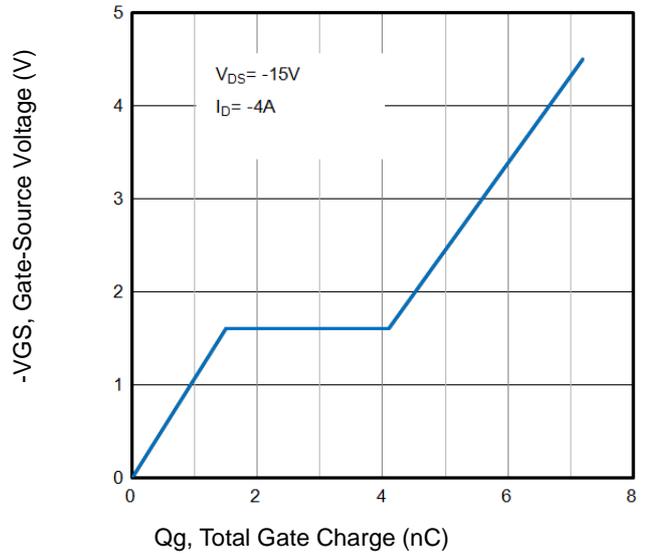


Fig8. Typical Gate Charge Vs. Gate-Source Voltage

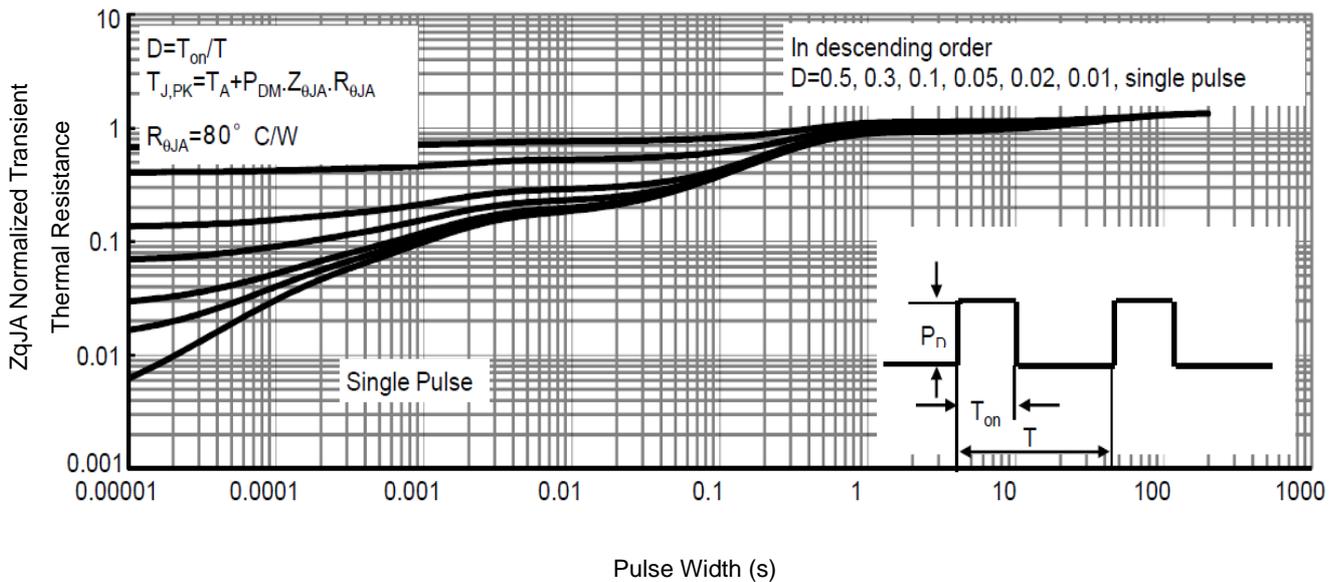


Fig9. Normalized Maximum Transient Thermal Impedance

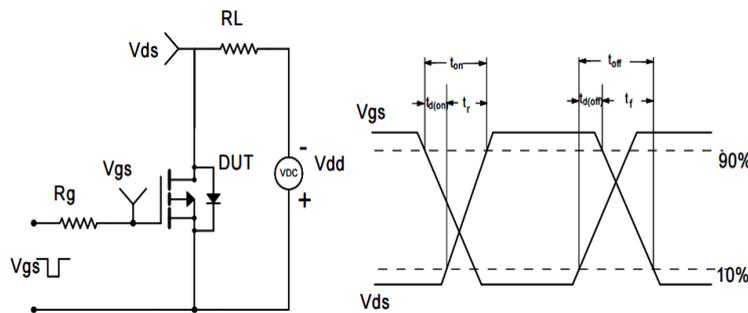
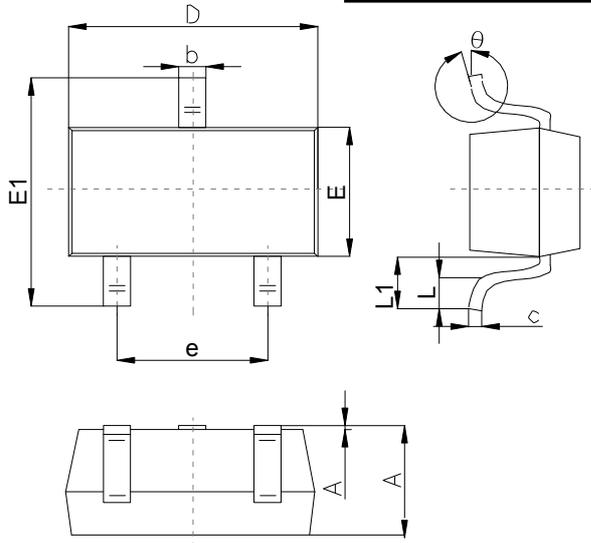
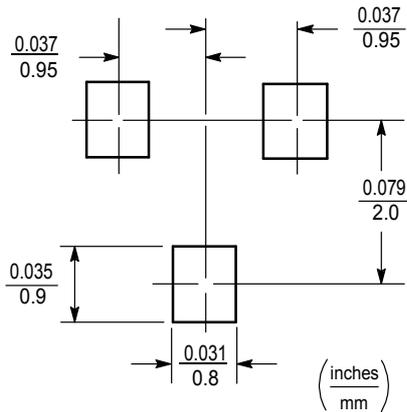


Fig10. Switching Time Test Circuit and waveforms

Outline Drawing
SOT-23 Package Outline Dimensions


Symbol	Dimensions In Millimeters		
	Min	Typ	Max
A	0.90		1.40
A1	0.00		0.10
b	0.30		0.50
c	0.08		0.20
D	2.80	2.90	3.10
E	1.20		1.60
E1	2.25		2.80
e	1.80	1.90	2.00
L	0.10		0.50
L1	0.4		0.55
θ	0°		10°

Suggested Pad Layout

Note:

1. Controlling dimension: in/millimeters.
2. General tolerance: $\pm 0.05\text{mm}$.
3. The pad layout is for reference purposes only.